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	First Named Inventor:	
	Alvin Lo et al.	
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	December 3, 2003	2171

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
/CT/AA	6,807,518	10/2004	Lang	703	2	
/CT/AB	7,111,010	06/2006	Chen	707	102	
/CT/AC	US Pub. 03/0187756	10/2003	Klivington et al.	705	27	
/CT/AD	US Pub. 02/0070953	06/2002	Barg et al.	345	700	
/CT/AE	US Pub. 05/0120021	06/2005	Tang et al.	707	010	
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/CT/AG	US Pub. 03/0120593	06/2003	Bansal et al.	705	39	
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	Document No.	Date	Country	Class	Sub Class	Translation Yes No
AR						
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AT						

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

/CT/AU	"A survey of approaches to automatic schema matching", Ram et al. The VLDB Journal 10:334-350, Feb. 2001
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EXAMINER:

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